


<b>Search Notes</b>  	<b>Application/Control No.</b>  10594021	<b>Applicant(s)/Patent Under Reexamination</b>  PELZER, HEIKO
	<b>Examiner</b>  JENNIFER F HU	<b>Art Unit</b>  2821

SEARCHED			
Class	Subclass	Date	Examiner
343	700MS	10/23/2008	Jennifer Chang
343	745	9/14/2009	JH

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search History	9/14/2009	JH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/JENNIFER F HU/ Examiner.Art Unit 2821	
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